List of Contents

Page

Abstract (Chinese)……i
Abstract (English)……ii
List of Contents……iii
List of Tables……v
List of Figures……vii

Chapter 1. Introduction……1

1.1 Background……1
1.2 Motivation……2
1.3 Previous Efforts……2
1.4 Research Objectives……3
1.5 Organization……3

Chapter 2. Frequency Approach for Measuring Process Capability……5

2.1 The Index C_p ……5

2.1.1. Process Quality and the Index C_p
2.1.2. Estimation of C_p
2.1.3. Distributional and Inferential Properties of the Estimated C_p
2.1.4. Hypothesis Testing with C_p

2.2 The Index C_{pk} ……7

2.2.1. Process Quality and the Index C_{pk}
2.2.2. Estimation of C_{pk}
2.2.3. Distributional and Inferential Properties of the Estimated C_{pk}
2.2.4. Hypothesis Testing with C_{pk}

2.3 The Index C_{pm} ……10

2.3.1. Process Quality and the Index C_{pm}
2.3.2. Estimation of C_{pm}
2.3.3. Distributional and Inferential Properties of the Estimated C_{pm}
2.3.4. Hypothesis Testing with C_{pm}

2.4 The Index C_{pmk} ……16

2.4.1. Process Quality and the Index C_{pmk}
2.4.2. Estimation of C_{pmk}
2.4.3. Distributional and Inferential Properties of the Estimated C_{pmk}
2.4.4. Hypothesis Testing with C_{pmk}

2.5 The Index C_{PU} and C_{PL} ……19

2.5.1. Process Quality and the Indices C_{PU} and C_{PL}
2.5.2. Estimations of C_{PU} and C_{PL}
2.5.3. Distributional and Inferential Properties of the Estimated C_{PU} and C_{PL}
2.5.4. Hypothesis Testing with C_{PU} and C_{PL}

Chapter 3. Bayesian Approach for Assessing Process Capability Based on Single Sample……22

3.1 Introduction ……22

3.2 Bayesian Approach for C_{pk} 24

3.2.1. The Posterior Probability p with C_{pk}
3.2.2. Bayesian Procedure for Testing C_{pk}

3.3 Bayesian Approach for C_{PU} and C_{PL} 28

3.3.1. The Posterior Probability p with C_{PU} and C_{PL}
3.3.2. Bayesian Procedure for Testing C_{PU} and C_{PL}

3.4 Application Examples 31

3.4.1. Example 1: Assessing Oil-hydraulic Cylinder Process Capability
3.4.2. Example 2: Assessing EEPROM Chip Process Capability

Chapter 4. Bayesian Approach for Assessing Process Capability Based on Multiple Samples.....34

4.1 Introduction.....34

4.2 Bayesian Approach for C_p Based on Multiple Samples.....36

4.2.1. Estimation of C_p Based on Multiple Samples
4.2.2. Posterior Probability p with C_p Based on Multiple Samples

4.3 Bayesian Approach for C_{pk} Based on Multiple Samples.....39

4.3.1. Estimation of C_{pk} Based on Multiple Samples
4.3.2. Posterior Probability p with C_{pk} Based on Multiple Samples

4.4 Bayesian Approach for C_{pm} Based on Multiple Samples.....40

4.4.1. Estimation of C_{pm} Based on Multiple Samples
4.4.2. Posterior Probability p with C_{pm} Based on Multiple Samples

4.5 Bayesian Approach for C_{PU} and C_{PL} Based on Multiple Samples.....43

4.5.1. Estimations of C_{PU} and C_{PL} Based on Multiple Samples
4.5.2. Posterior Probability p with C_{PU} and C_{PL} Based on Multiple Samples

4.6 Application Examples 44

4.6.1. Example 1: Assessing the Resistor Process Capability
4.6.2. Example 2: Assessing the Single Coupler Process Capability

Chapter 5. Conclusions and Recommendations.....48

5.1 Conclusions.....48
5.2 Recommendations.....49

Appendix I.....51
Appendix II.....54
Appendix III.....56
References.....58
Tables.....64